Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10561014	PAN ET AL.
Examiner	Art Unit
Chang-Yu Wang	1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES			
Search Notes	Date	Examiner	
Sequence search: SEQ ID NOs:1, 3 and 36 regular and oligomer search. See search results in SCORE (6/18/08).	8/25/08	CYW	
EAST, STN: search strategy attached.	8/25/08	CYW	
Inventor name search: EAST, STN, PALM.	8/25/08	CYW	
PLUS search from STIC. See search results in eDAN (6/23/08).	8/25/08	CYW	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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